# A wealth of Applications

# Integration example

The VMU series provides a wide range of small, lightweight microscope units to be integrated into automatic optical inspection devices (AOI) and repair equipment of all sizes.

Laser applications



UV laser application using VMU-L4B (Source of photographs: V-Technology Co.,Ltd.)



UV laser application using VMU-L4B (Source of photographs: HOYA CANDEO OPTRONICS CORPORATION)





SEM photograph of IC surface after removing upper layer



Color filter working

Objectives compatible with YAG lasers (1064 nm, 532 nm, 355 nm and 266 nm) allow high precision and quality working.

- Using a simplified stand, it can be used as a compact microscope.
- > Peeling off protective films and organic thin-films
- > Cutting of IC wiring (Au, Al) and exposure of lower layer pattern
- > FPD defects repair
- > Photomask repair
- > Marking, trimming, patterning, spot annealing and scribing Various lasers are supported including femtosecond lasers. (For details, please inquire.)

#### Digital microscope systems



By installing a digital camera on a microscope the VMU provides a simple and compact system which allows microphotography and simultaneous external monitor observations. The VMU can be used in vertical and inverted positions according to your application requirements.

Using a simplified stand, it can be used as a compact microscope.

> Microphotography and observation of metallic, resinous and printed surfaces > Micro-fluid analysis

> Cell and microorganism observation/analysis

#### IR analysis/inspection



Optical systems using Mitutoyo M Plan Apo NIR objectives that cover a wide range of wavelength from visible to infrared are providing solutions on the production line and in the laboratory. Nondestructive inspection is made possible by using an infrared source.

- > Thickness measurement of LCD thin-film and silicon board film
- > Internal inspection/analysis and 3D evaluation of MEMS devices
- > Internal observation of IC packages, void inspection/evaluation sensor of wafer junctions
- > Spectral characteristics analysis using an infrared source

#### Dual-camera (high & low magnification) observation



### Microscope unit for incorporating in Equipment VMU



Objectives shown mounted on tubes are optional.

#### Features

> Small, lightweight microscope unit (Suitable for observing a wide range of objects: metal, resin, printed surfaces, minute mechanisms, etc.)

- > Can used with YAG (near-infrared, visible, near-ultraviolet, or ultraviolet) lasers.\*1 (Suitable for cutting, trimming, repair and marking of IC wiring (Au, Al), removing and processing thin-film (insulating film) and repair of color filters (defects repair).)
- > Compatible with infrared optical systems\*2
- > Equipped as standard with a telecentric illumination system with aperture diaphragm for epi-illumination optical systems (This is the best illumination system for image processing applications (e.g. dimension measurement, form inspection and positioning) which require even lighting.)
- > Models with enhanced rigidity and performance (VMU-LB / VMU-L4B).

> Custom-order is available to meet the customers' requirements (Dual-camera, double magnification (high & low), etc.)

\*1: The performance and safety of laser-equipped system products is not guaranteed.

\*2: An infrared source and infrared camera are necessary. For more details on infrared observation, contact your local Mitutoyo sales office.

#### **Specifications**

Model No.			VMU-V	VMU-H	VMU-LB	VMU-L4B
Order No. Camera mounting orientation			378-505	378-506	378-513	378-514
		ntation	Vertical	Horizontal	Vertical (rotatable)	
Observat	Observation		Bright-field/Erect image	eld/Erect image Bright-field/Inverted image Bright-fiel		/Erect image
Optical tube	Camera port	Optical features	Magnification: 1X; Wavelength (λ): visible radiation			
		Mount	C-mount (centering and parfocal adjus		istment)	C-mount with centering and parfocal adjustment and green filter switch
	Tube lens (correction range)		Built in 1X (visible - NIR)		Built in 1X (NUV - visible - NIR)	Built in 1X (UV - visible - NIR)
	Laser port	Optical features			Magnification: 1X λ; 355/532/1064 μm	Magnification: 1X λ: 226/355/532/1064 μm
		Mount	-		With parfocal adjustment	
		Suitable YAG laser type *2	-		Fundamental, second and third- harmonic mode	Fundamental and second, third and fourth-harmonic mode
	Polarizer unit *1		Available for observation		Available for observation and laser applications	Available for observation and laser applications
		For observation		M Plan Apo	/HR/SL, G Plan Apo	
Suitable (optional	objective )	For laser cutting	-		M/LCD Plan Apo NIR. M/LCD Plan Apo NUV Note: Selected depending on the wavelength of the laser source	M/LCD Plan Apo NIR. M/LCD Plan Apo NUV, M Plan UV Note: Selected depending on the wavelength of the laser source
Applicab	le camera			2/3 i	nch or smaller	
Optical s	ystem epi-illun	nination		Telecentric wi	th aperture diaphragm	
Illuminat	ed lens tube			Bright-field	illuminated lens tube	
Illuminat	ion unit (optio	nal)		Fiber-optic illumination	1 unit (12 V, 100 W) ( <b>378-700</b> )	
Main uni	t mass		650 g	750 g	1270 g	1300 g

\*1: M Plan Apo 1X objective should be used together with a polarizer (378-710 or 378-715).

Note: Observe the following precautions when using VMU-LB or L4B with YAG laser source attached.

Be aware of the laser power and energy density. Otherwise, the optical system may be damaged.
Check the mass of the laser source. When mounting on a high-speed device or acceleration/deceleration device, please contact us.







Objectives shown mounted on tubes are optional.

#### Features

Model No.

Order No.

Observation

Applicable camera

Illumination unit (optional) \*2

Optical

tube

- > Observation over a wide field of view (Image field of ø30 mm)
- > Greatly enhanced brightness on the periphery of the field of view (Reduces the dependence on the light distribution characteristics.)
- > Compatible with infrared optical systems\*1
- > Small optical observation system (Refer to page 35 for the dimensions.)
- > Compatible with HR series of high resolving power lens (Designed

with pupil diameter of ø16.8)

\*1: An infrared source and infrared camera are necessary. For more details on infrared observation, contact your local Mitutoyo sales office.





Dark-field

Bright-field Specifications

For Bright-field Observation For Bright/Dark-field Observation WIDE VMU-HR WIDE VMU-BDV WIDE VMU-BDH 378-519 378-517 378-518 Camera mounting orientation Vertical Vertical Horizontal Bright-field/Erect image Bright/Dark-field/Erect image Bright/Dark-field/Inverted image Magnification: 1X Visible light - Infrared light Magnification: 1X Visible light Optical system F-Mount, C-Mount (with aligning and parfocal adjustment mechanism) Camera Mount Imaging forming (tube) lens Built in 1X (visible - NIR) Built in 1X (visible) Image field ø30 Polarized unit \*1 Mountable Objective lens (required option) M Plan Apo, M Plan Apo HR, M Plan Apo SL, G Plan Apo, NIR series **BD** Plan Apo Diagonal line length: 30 mm or less (equivalent to APS-C format) Telecentric illumination, Bright/Dark-field illumination optical tube Telecentric (Pupil diameter of ø16.8) (Dual-port fiber-optic illumination) \*Coaxial epi-illumination, with aperture diaphragm Bright/Dark-field switching with light source on-off

Fiber-optic illumination unit (12 V, 100 W) (No. 378-700)

Optical system epi-illumination Bright-field illuminated lens tube (rotatable) \*3, selectable between LED Illuminated lens tube Bright-field illuminated lens tube (rotatable) \*3

adapter and fiber adapter (both supplied as standard)

Main unit mass 1400 g 2000 g 2150 g \*1: Polarized observation by Bright-field illumination \*2: Support for third-party LED illuminators (WIDE VMU-HR only) \*3: The fiber (light source) mount orientation can be changed.



- > Observation over a wide field of view (Image field of ø30 mm)
- > Available for various observation methods (Including bright-field, dark-field for visual or scratch inspection, and polarized observation of objects with polarization characteristics)

# VMU

#### System diagram



# WIDE VMU-HR / WIDE VMU-BD

#### System diagram

